PATENT ABSTRACTS OF JAPAN

(11)Publication number:

10-041409

(43)Date of publication of application: 13.02.1998

(51)Int.CI.

H01L 21/8244 H01L 27/11 H01L 27/10 H01L 27/108 H01L 21/8242

(21)Application number: 08-211856

(71)Applicant: SONY CORP

(22)Date of filing:

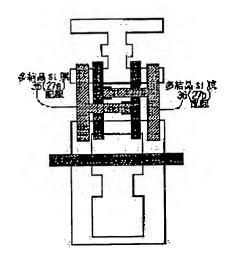
23.07.1996

(72)Inventor: KOSHIO KENJI

(54) SEMICONDUCTOR DEVICE

(57)Abstract: PROBLEM TO BE SOLVED: To enable the wiring density to

be lowered by a memory cell of a SRAM by providing the first and second cells with the wiring formed of the same semiconductor layer following the second layer. SOLUTION: The wirings 27a, 27b for intersection coupling are formed of polycrystalline Si film 36 in the same layer as the polycrystalline Si layer used for the formation of the electrode, etc., of capacitance element in the memory cell of a DRAM to be the polycrystalline Si film after the second layer on an Si substrate. Next, the polycrystalline Si film 36, etc., are covered with an interlayer insulating film. In the memory cell of SRAM in ASIC, the wirings 27a, 27b for intersection coupling are formed of the polycrystalline Si film 36 in the same layer as that of the polycrystalline Si film for the formation of the electrode, etc., of capacity in the memory cell of a DRAM. Accordingly, in comparison with the memory cell of SRAM in the ASIC forming the wirings 27a, 27b of Al films, the density of the Al film wiring is lower than that of the memory cell so that the wirings 27a, 27b



may be hardly affected by pattern deformation, or raising dust in the wiring formation step.

LEGAL STATUS

[Date of request for examination]

[Date of sending the examiner's decision of rejection]

[Kind of final disposal of application other than the examiner's decision of rejection or application converted registration]

[Date of final disposal for application]

		3
		,
	,	
4		
		1

[Patent number]

[Date of registration]

[Number of appeal against examiner's decision of rejection]

[Date of requesting appeal against examiner's decision of rejection]

[Date of extinction of right]

Copyright (C); 1998,2003 Japan Patent Office

